Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 2 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, covering the cost of warranty returns BOTH ways (plus supplying a loan unit, if available) and supplying a free business tool with every order.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based near Heathrow Airport in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

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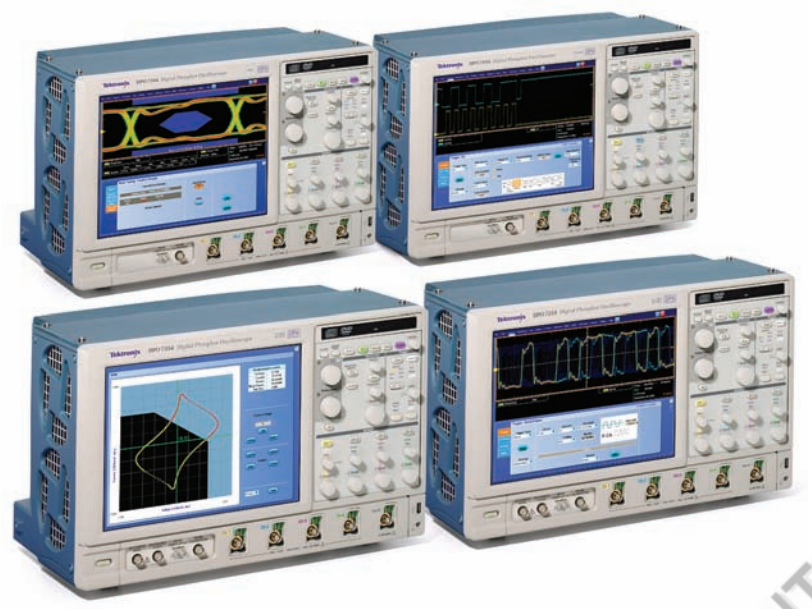
Digital Phosphor Oscilloscopes

DPO7000 Series



Unmatched Performance for Greater Insight Into Your Design to Get Your Work Done Faster

The DPO7000 Series are the new generation of real-time digital phosphor oscilloscopes and are the industry's best solution to the challenging signal integrity issues faced by designers verifying, characterizing, debugging and testing sophisticated electronic designs.

The family features exceptional performance in signal acquisition and analysis, operational simplicity and unmatched debugging tools to accelerate your day-to-day tasks. The largest screen in the industry and the intuitive user interface provide easy access to the maximum amount of information.

Unmatched Acquisition Performance

Signal Fidelity of Tektronix Oscilloscopes Ensures Confidence in Your Measurement Results

– High sample rate on all models, on all channels, to capture more signal details (transients, imperfections, fast edges)

– 40 GS/s on one channel on the 2.5 GHz and 3.5 GHz models

– Option 2SR to double the maximum real-time sample rate for the 500 MHz and 1 GHz models

– High bandwidth up to 3.5 GHz, matched across 2, 3 or 4 channels and enabled by Tektronix proprietary DSP enhancement. The user-selectable DSP filter on each channel provides magnitude and phase correction plus extension to 3.5 GHz for more accurate signal fidelity for complex measurements. The DSP filter on each channel can also be switched off to take advantage of true 2.5 GHz analog bandwidth for applications needed the highest available raw data capture.

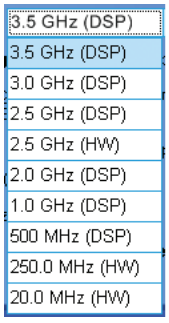
– The DPO7000 Series oscilloscopes include as a standard feature a series of user-selectable bandwidth limit filters. These filters preserve the instrument's bandwidth roll-off characteristics, flatness and phase linearity within the new frequency range, thereby reducing the effects of out-of-band noise on measurements. Now, designers can purchase one instrument for their highest bandwidth needs and easily optimize it to handle lower-frequency measurements as well.

– Very low jitter noise floor and vertical accuracy for very accurate measurements

– Longest acquisition of the industry to provide more resolution and longer time sequence

– Standard 10 million data points per channel on the DPO7000 Series

– Optional up to 400 million total data points on 2.5 GHz and 3.5 GHz models



User-selectable bandwidth limiting choices.

Features & Benefits

3.5 GHz bandwidth model for serial and digital applications

2.5 GHz, 1 GHz and 500 MHz bandwidth models for all applications

Up to 40 GS/s real-time sample rate on one channel and up to 10 GS/s on all four channels

Up to 400 megasamples record length with MultiView Zoom™ feature for quick navigation

>250,000 WFMS/s maximum waveform capture rate

User-selectable bandwidth limit filters for better low-frequency measurement accuracy

MyScope® custom windows and right mouse click menus for exceptional efficiency

Event search and mark to facilitate the comprehension of event relationships

Pinpoint® triggering provides the most flexible and highest performance triggering, with over 1400 combinations to address virtually any triggering situation.

Small footprint and light weight

12.1 largest XGA touch-screen display in the industry

Communications mask testing

Clock recovery from serial data streams

64 bit NRZ serial pattern trigger for isolation of pattern-dependent effects up to 1.25 Gb/s

NRZ serial test pattern triggering

Low-speed serial protocol triggering (I2C, SPI, RS-232, CAN)

Technology-specific software solutions provide built-in domain expertise for Ethernet, USB 2.0 compliance testing, jitter, timing, eye diagram, power, DDR memory bus analysis, CAN and LIN network design

OpenChoice® software with Microsoft Windows XP OS enables built-in networking and extended analysis

Applications

Signal integrity, jitter and timing analysis

Verification, debug and characterization of sophisticated designs

Debugging and compliance testing of serial data streams for telecom and datacom industry standards

Low-speed serial bus design (I2C, SPI, CAN, LIN, RS-232)

Investigation of transient phenomena

Power measurements and analysis

Spectral analysis

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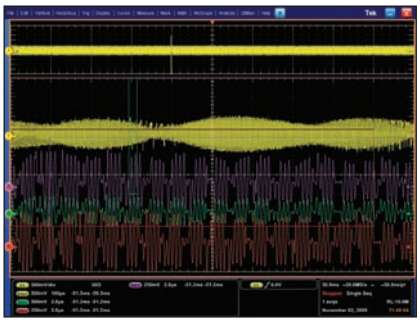
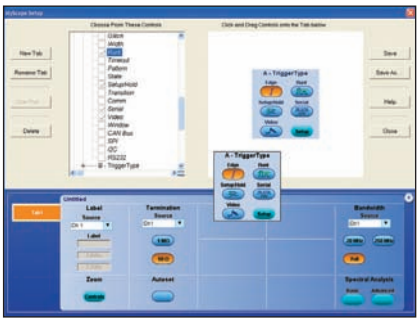
Tektronix®



Zoom in on four areas of interest simultaneously to compare them.

Tektronix Active probes achieve high-speed signal acquisition and measurement fidelity.



Drag and drop menu items of interest to create the MyScope control window.

– Optional up to 200 million total data points on the 500 MHz and 1 GHz models

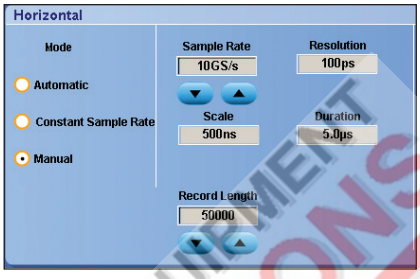
– Easily manage this deep record length, provide detailed comparison and analysis of multiple waveform segments with the MultiView Zoom™ feature. Automatically scroll through deep records visually or create a math expression to instantly highlight differences

– Highest performance probing solutions for differential and single-ended voltage signals as well as current measurement, because accurate design verification depends on high-bandwidth access to critical signals and high-fidelity signal capture

Unmatched Versatility

Get the Most of Your Oscilloscope by Fully Controlling its Waveform Acquisition and Display Parameters

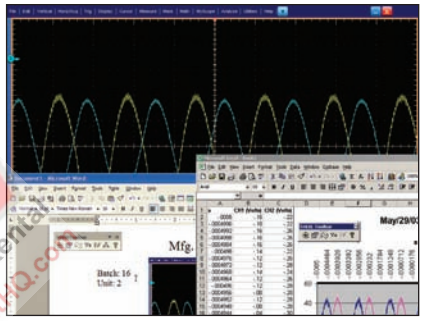
You have the choice of three horizontal time base modes of operations. If you are simply doing signal exploration and want to interact with a lively signal, you will use the *Automatic* or interactive default mode that provides you with the liveliest display update rate. If you want a precise measurement and the highest real-time sample rate that will give you the most measurement accuracy, then the *Constant Sample Rate* mode is for you. It will maintain the highest sample rate and provide the best real-time resolution. The last mode is called the *Manual* mode because it ensures direct and independent control of the sample rate and record length.



3 modes of operation of the horizontal time base.

With the MyScope® Feature, Create Your Own Control Windows With Only the Controls, Features and Capabilities that You Care About

Easily create your own personalized "toolbox" of oscilloscope features in a matter of minutes using a simple, visual, drag-and-drop process. Once created, these custom control windows are easily accessed through a dedicated MyScope button and menu selection on the oscilloscope button/menu bar, just like any other control window. You can make an unlimited number of custom control windows, enabling each person who uses the oscilloscope in a shared environment, to have their own unique control window. MyScope control windows will benefit all oscilloscope users, eliminating the ramp-up time that many face when returning to the lab after not using an oscilloscope for a while and enables the power user to be far more efficient. Everything you need is found in one control window rather than having to constantly navigate through menu after menu to repeat similar tasks.



Capture data into Microsoft Excel using the unique Excel toolbar and create custom reports using the Word toolbar.

With OpenChoice® Software, Customize Your Test and Measurement System with Familiar Analysis Tools

The analysis and networking features of OpenChoice software add flexibility to Tektronix' Windows XP oscilloscopes: Using the fast embedded bus, waveform data can be moved directly from acquisition to analysis applications on the Windows desktop at much faster speeds than conventional GPIB transfers. Tektronix' implementation of industry standard protocols, such as TekVISA™ interface and ActiveX controls, are included for using and enhancing Windows applications for data analysis and documentation. IVI-COM instrument drivers are included to enable easy communication with the oscilloscope using GPIB, serial data and LAN connections from programs running on the instrument or an external PC. Or, use the Software Developer's Kit (SDK) to help create

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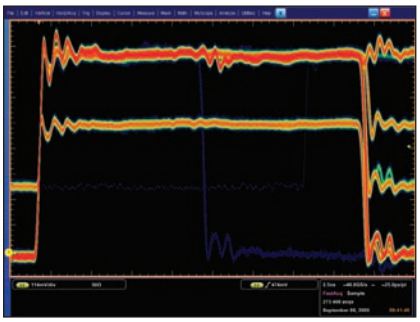
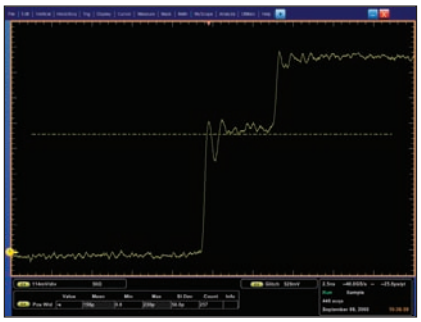


Maximize the probability of capturing elusive glitches and other infrequent events with FastAcq acquisition mode.



Isolate glitches down to 200 ps wide.

Isolate, setup and hold violations down to 360 ps.

custom software to automate multistep processes in waveform collection and analysis with Visual BASIC, C, C++, MATLAB, LabVIEW, LabWindows/CVI and other common Application Development Environments (ADE). Integration of the oscilloscope with external PCs and non-Windows hosts is also supported by the DPO7000 Series software solutions. In addition, the OpenChoice architecture provides a comprehensive software infrastructure for faster, more versatile operations. Data transfer programs, such as the Excel or Word toolbar, are used to simplify analysis and documentation on the Windows desktop or on an external PC.

Accelerate the Debug of Complex Electrical Designs

FastAcq Acquisition Mode Expedites Debugging by Clearly Showing Imperfections

More than just color-grading, FastAcq enabled by Tektronix proprietary DPX® acquisition technology, captures signals up to more than 250,000 waveforms per second on all 4 channels simultaneously, dramatically increasing the probability of discovering infrequent fault events. And with a simple turn of the intensity knob you can clearly see "a world others don't see," because frequency of occurrence is color coded. Some oscilloscope vendors claim high waveform capture rates for short bursts of time, but only the DPO7000 Series, enabled by DPX technology, can deliver these fast waveform capture rates on a sustained basis — saving minutes, hours or even days by quickly revealing the nature of faults so sophisticated trigger modes can be applied to isolate them.

The Ability to Trigger an Oscilloscope on Events of Interest is Paramount in Complex Signal Debug and Validation

Whether you're trying to find a system error or need to isolate a section of a complex signal for further analysis, like a DDR read or write burst, Tektronix' Pinpoint® triggering provides the solution. The Pinpoint trigger system uses Silicon Germanium (SiGe) technology to provide trigger sensitivity of up to the bandwidth of the instrument and allows selection of most trigger types on both A and B trigger circuits. It can capture very narrow glitches with very little trigger jitter. Other trigger systems offer multiple trigger types only on a single event (A event), with delayed trigger (B event) selection limited to edge type triggering and often do not provide a way to reset the trigger sequence if the B event doesn't occur. But Pinpoint triggering provides a full suite of advance trigger types on both A and B triggers with reset triggering to begin the trigger sequence again after a specified time, state or transition so that even events in the most complex signals can be captured. Other oscilloscopes typically offer less than 20 trigger combinations; Pinpoint triggering offers over 1400 combinations, all at full performance.

With enhanced triggering, you can choose to compensate for the difference in time there is between the trigger path and the display path and eliminate virtually any trigger jitter at the trigger point. In this mode, the trigger point can be used as a measurement reference.

Trigger on the Most Relevant Bit Sequence of the Industry Standard Serial Bus

I^2C (Inter-Integrated Circuit) triggering is a standard feature and includes Start condition, Missing Acknowledge, Restart, Data Read, Address and/or Data Frame, in a 10 bit or 7 bit format with a specific selection to choose whether or not to include the R/W bit.

SPI (Serial Peripheral Interface) triggering is a standard feature and includes triggering on a data pattern within a user-definable frame. RS-232 triggering is a standard feature.

CAN (Controller Area Network) triggering is an optional feature (Opt. LSA) and includes synchronization to the Start or End of a CAN frame on any CAN high or CAN low signal, triggering on Type of Frame (Data, Remote, Overload), Identifier, Data, Missing Acknowledge and Bit Stuffing error.

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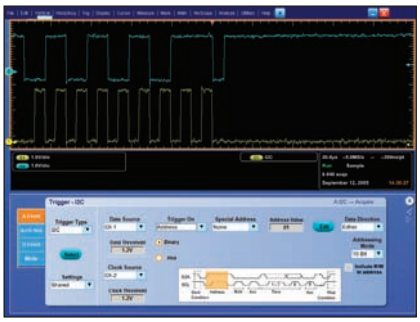
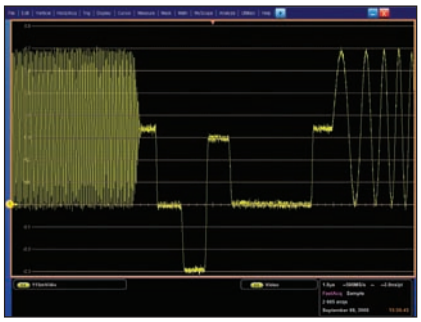


Easily trigger on a specific I²C address.



Triggering on an analog HDTV tri-level sync signal and examining horizontal blanking interval.

Serial pattern triggering to debug pattern dependent issues.

Analog HDTV/EDTV Triggering for emerging standards like 1080i, 1080p, 720p and 480p as well as standard video triggering on any line within a field, all lines, all fields, odd or even fields for NTSC, SECAM and PAL video signals. In addition, IRE and mV graticules can be selected for easier measurements and visual inspection. This is a standard feature.

Serial Pattern Triggering: To debug serial architectures, use the serial pattern triggering option for NRZ serial data stream with built-in clock recovery (available on models DPO7254 and DPO7354 only). The instrument can recover the clock signal, identify the transitions and decode characters and other protocol data. With the combination of the Serial Trigger and Protocol Decode software, you can see the captured bit sequences decoded into their words for convenient analysis (for 8 b/10 b and other encoded serial data streams) or you can set the desired encoded words for the serial pattern trigger to capture. This serial trigger option covers NRZ serial standards up to 1.25 Gb/s.

Pattern Lock Triggering adds a new dimension to NRZ serial pattern triggering by enabling the oscilloscope to take synchronized acquisitions of a long serial test pattern with outstanding time base accuracy. Pattern lock triggering can be used to remove random jitter from long serial data patterns. Effects of specific bit transitions can be investigated and averaging can be used with mask testing. This feature is included as part of Option PTM on the DPO7254 and 7354 models.

Large 12.1-inch XGA Display Screen

The DPO7000 Series has the largest display in the industry with a 12.1" XGA touch screen that gives up to 15% more waveform display than other oscilloscope series in its class.

10 vertical divisions give you 25% more vertical measurement resolution.

Unmatched Usability

The TekVPI™ probe interface provides versatility and ease of use enabled by intelligent bi-directional oscilloscope-to-probe communication.

The DPO7000 Series are fast-responding instruments and contain a comprehensive suite of features, such as a touch-screen, shallow menu structures, intuitive graphical icons, knob per channel vertical controls, support for right mouse clicks, mouse wheel improvements, saving of waveforms and measurements available in Preview mode, Export/Save/Recall menu improvements.

Interoperability with Logic Analyzers for Digital Design and Debug

Tektronix' Integrated View (iView™) data display enables digital designers to solve signal integrity challenges and effectively debug and verify their systems more quickly and easily. This integration allows designers to view time-correlated digital and analog data in the same display window and isolate the analog characteristics of the digital signals that are causing systems failures. No user calibration is required. And, once set up, the iView feature is completely automated.

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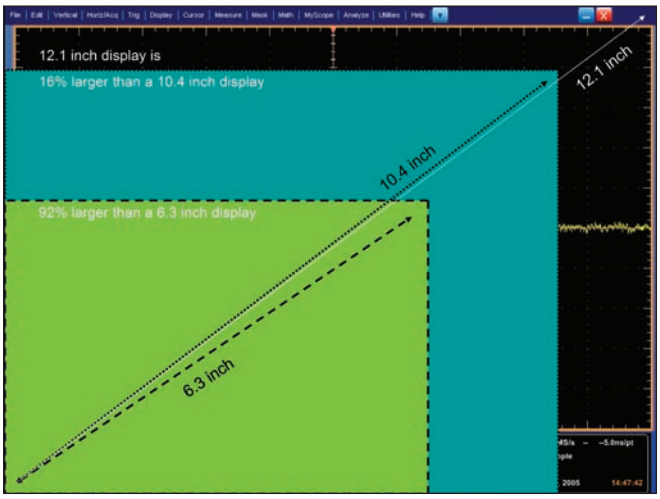
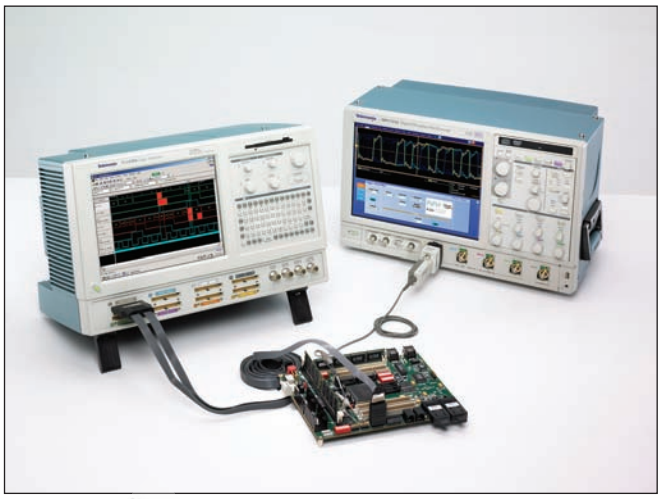


How does 12.1" display compare to the display size of other oscilloscopes?



An integrated toolset for digital design and troubleshooting.

More Insight into Your Complex Electrical Design for Characterization and Compliance Testing

Such as a simple math expression, waveform mask testing, a pass/fail compliance test, event searching, event marking or a custom application that you develop yourself, the DPO7000 Series Oscilloscopes offer the industry's most comprehensive set of analysis and compliance tools.

A Wide Range of Built-in Advanced Waveform Analysis Tools

Waveform cursors make it easy to measure trace-to-trace timing characteristics, while cursors that link between YT and XY display modes make it easy to investigate phase relationships and Safe Operating Area violations. Select from 53 automatic measurements using a graphical palette that logically organizes measurements into Amplitude, Time, Combination, Histogram and Communications categories. Gather further insight into your measurement results with statistical data such as mean, min, max, standard deviation and population.

Define and apply math expressions to waveform data for on-screen results in terms that you can use. Access common waveform math functions with the touch of a button. Or, for advanced applications, create algebraic expressions consisting of live waveforms, reference waveforms, math functions, measurement values, scalars and user adjustable variables with an easy-to-use calculator-style editor.

FFT – To analyze your signal in the spectral domain, use the basic spectral (provides you with the best parameter) or use advanced spectral with the manual time base horizontal mode (to directly control the frequency span, center frequency and resolution bandwidth).

Basic spectral UI control window.

Filtering – Enhance your ability to isolate or remove some important component of your signal (noise or specific harmonics of the signal) by creating your own filters or using the filters provided as standard with the instrument.

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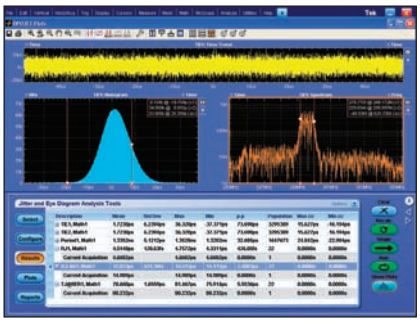
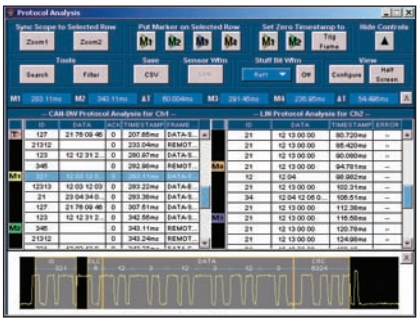


Jitter, Timing and Eye Diagram Analysis.

Accelerating the research of specific events in an acquired waveform.



CAN and LIN Timing and Protocol Decode.

Jitter, Timing and Eye Diagram Analysis

Jitter, Timing and Eye Diagram Analysis (Opt. DJA) – Tight timing margins associated with today's serial buses demand stable, low jitter designs. DPOJET extends the oscilloscope capability by making jitter, timing and eye diagram measurements over contiguous clock and data cycles in a single-shot real-time acquisition. With multiple measurements and a variety of analysis tools including spectral and trend plots, DPOJET quickly shows system timing under variable conditions. It also provides Rj/Dj on signals without a repeating pattern and without requiring a fixed pattern or length. You can get insight into the signal characteristics like SSC profile using the analysis features and perform pass-fail testing using eye-diagram masks and limit files for testing against statistical limits using the compliance features.

This tool is available for the DPO7000 Series as Opt. DJA and Opt. DJE.

Advanced Event Search and Mark (Opt. ASM) – Event Search and Mark will relieve the user from the tedious task of examining data by highlighting important events, skipping the unimportant ones and enhancing the comprehension of event relationships.

You can navigate between the events of interest effortlessly. A basic event (edge-only) search and mark is provided as a standard feature; and support for more advanced event types like transition, setup and hold or logic pattern, is provided with the ASM option.

Limit Testing (Opt. LT) – This feature consists of comparing an acquired waveform to boundaries. These boundaries are typically defined by the user to specify a tolerance band around a reference waveform. If any part of the acquired waveform falls outside of the limit, the software returns a failure message and the location of the failure is shown on the waveform.

Communications Mask Testing (Opt. MTM) – This feature provides a complete portfolio of masks for verifying compliance to serial communications standards. It supports 156 Standards Masks –

– ITU-T (64 Kb/s to 155 Mb/s)

– ANSI T1.102 (1.544 Mb/s to 155 Mb/s)

– Ethernet IEEE 902.3, ANSI X3.263 (125 Mb/s to 1.25 Gb/s)

– Sonet/SDH (51.84 Mb/s to 622 Mb/s)

– Fibre Channel (133 Mb/s to 2.125 Gb/s)

– USB (12 Mb/s to 480 Mb/s)

– IEEE 1394 (491.5 Mb/s to 1.966 Gb/s)

– RapidI/O (up to 2 Gb/s)

– OIF Standards (1.244 Gb/s)

– Video (143.18 Mb/s to 1.485 Gb/s)

CAN and LIN Timing and Protocol Decode Software (Opt. LSA) – When you need to ensure seamless and reliable operation of a CAN or LIN network, this option enables CAN bus triggering and provides the solution to measure oscillator tolerance, propagation delay and simultaneously decode CAN and LIN messages, with the protocol leveraging the trigger capabilities.

This option is offered on DPO7354, DPO7254, DPO7104 and DPO7054 as Opt. LSA.

Optional Power Measurement and Analysis (Opt. PWR) – Analyze power dissipation in power supply switching devices and magnetic components and generate detailed reports in customizable formats. The HiRes acquisition mode delivers greater than 8 bits of vertical resolution on single-shot or repetitive signals at bandwidth up to 125 MHz. The powerful and flexible measurements, math and math-on-math capabilities make it an ideal solution for performing power measurements, such as voltage, current, instantaneous power and energy, for power-device designers. The new TekVPI™ interface provides smart communication between the oscilloscope and the probe. TekVPI probe interface also provides more power to the probe interface, allowing customers to directly connect current probes to the front of the oscilloscope.

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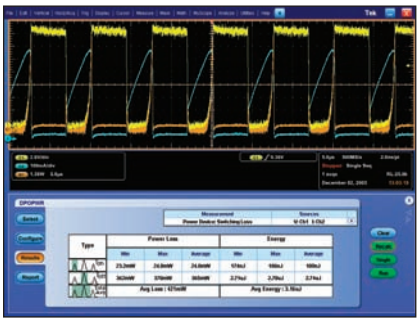


Power Measurement and Analysis.

USB compliance testing.

UWB WiMedia analysis and measurements.

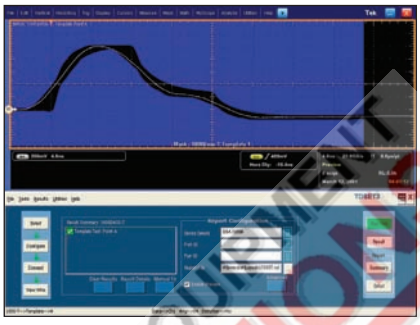
Optional Ethernet Compliance Testing (Opt. ET3) – Provides compliance testing for 10/100/1000Base-T signals.

Optional USB Compliance Testing (Opt. USB) – Provides compliance testing for USB 2.0 signals.

Optional DDR Memory System Analysis (Opt. DDRA) – Accelerate the validation of a memory system based on DDR1, LP-DDR1, DDR2, DDR3 or DDR variants technology, like GDDR3. This new DDR search algorithm automatically detects the rates and the voltage levels of the data and strobe signals and marks every occurrence of read or write bursts. You can then generate an eye-diagram of the data or perform JEDEC standard measurements qualified on read or write bursts with DPOJET.

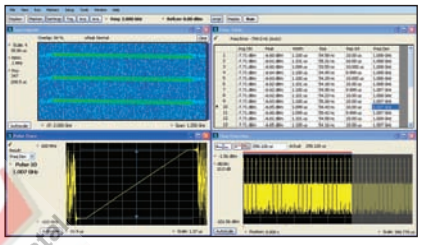
Optional Ultra-Wideband Spectral Analysis and Ultra-Wideband Spectral Analysis Essentials

UWBE: Ultra-Wideband microwave, optical and electrical signals require more real-time bandwidth than is possible with spectrum analyzer based solutions. Spectral analysis and digital down conversion of RF data is fast and easy and the down converted frequency span of interest may be exported for further analysis in tools such as RSAVu and MATLAB.



Ethernet compliance testing.

UWB in addition adds: With automatic packet, TFC and data rate detection, support for all band groups, Time Frequency Codes and data rates, WiMedia PHY 1.2 analysis provides a complete solution. Rapid visualization, debug and report generation of the spectrograms, power spectral density, QPSK/DCM constellations, EVM-vs-Symbol, EVM-vs-Subcarrier, Common-Phase-Error-vs-Symbol and Voltage-vs-Time plots and complete measurements are captured and documented for each test condition.



SignalVu™ enables detailed analysis in multiple domains.

SignalVu™ Vector Signal Analysis (Opt. SVE, SVP, SVM)

Easily validate wideband designs and characterize wideband spectral events. By combining the signal analysis engine of the RSA6100A Real-Time Spectrum Analyzer with that of the industry's widest bandwidth digital oscilloscopes, you can now evaluate complex signals up to 20 GHz without the need of an external down converter. You get the functionality of a vector signal analyzer, a spectrum analyzer and the powerful trigger capabilities of a digital oscilloscope – all in a single package. Whether your design validation needs include wideband radar, high data rate satellite links or frequency hopping communications, SignalVu™ vector signal analysis software can speed your time-to-insight by showing you time variant behavior of these wideband signals.

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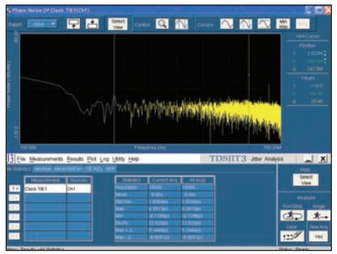
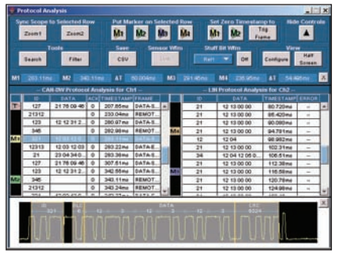
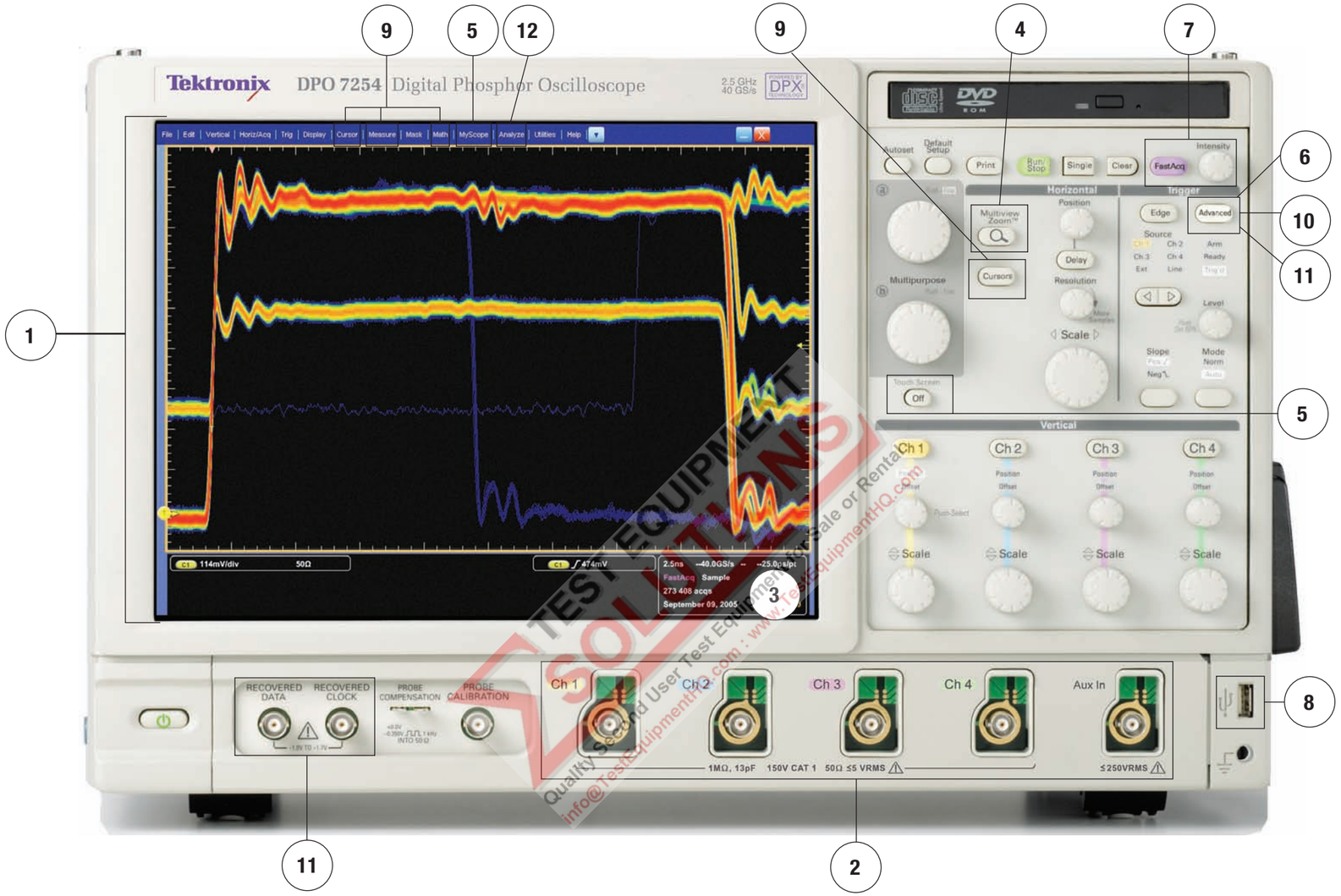
Basic spectral UI control window.

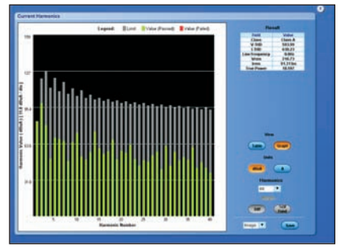


Jitter and Timing Measurement.



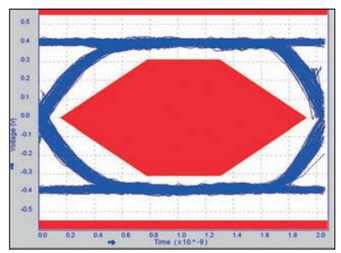
CAN and LIN Timing and Protocol Decode.





Power measurement.

Accelerate the research of multiple events in an acquired waveform.



Compliance testing for many serial standards like USB and Ethernet.

1 Large 12.1-inch XGA Touch Screen Display

The DPO7000 series touch screen gives up to 15% more waveform display than other oscilloscopes of its class.

2 New Probe Interface

TekVPI™ probe interface provides versatility and ease of use enabled by intelligent bi-directional oscilloscope-to-probe communication.

3 Exceptional Performance

The fastest waveform capture rate on the highest bandwidth oscilloscope in a mid-range offering with up to 40 GS/s real-time sample rate and 400 M record length on one channel.

4 With MultiView Zoom™

Easily dive into very long record of acquired data, analyze multiple waveform segments simultaneously and scroll automatically through the deepest records visually.

5 Unmatched Usability

With MyScope®, create your own control window with only the controls you care about. The versatile user interface allows you to use the touch screen or the mouse.

6 Accelerate the Debug of Complex Designs with Pinpoint® Triggering

Access up to 1400 trigger combinations to address virtually any triggering situations.

7 FastAcq Acquisition Expedites Debugging by Clearly Showing Faults

More than 250,000 waveforms per second and with a simple turn of the intensity knob, clearly see the frequency of occurrence.

8 Easy Connectivity

Built-in USB port at the front for easy access to save your work on a memory stick.

Most standard input/output ports available on the side of the instrument.

9 A Wide Range of Built-in Advanced Analysis Tools

Linked XY and YT cursors.

53 automatic measurements.

Waveform boundary tolerance testing.

Many math functions, some advanced (like FFT or Filtering).

10 For Insight into Your Low-speed Serial Designs

Serial Protocol Triggering for I^2C, SPI, CAN plus a complete CAN and LIN timing and protocol analysis software package.

11 For Insight into Your High-speed Serial Designs

Optional NRZ Serial Pattern triggering plus Recovered Clock and Recovered Data available on the front of the DPO7254 or the DPO7354 instruments.

12 A Breadth of Optional Software Packages for Expanded Waveform Analysis

Event Search and Mark for faster event analysis.

Advanced Jitter and Timing, application-specific and compliance measurements and tests.

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Characteristics

Vertical System

	DPO7054	DPO7104	DPO7254	DPO7354
Input Channels	4			
Bandwidth (DSP Bandwidth Enhance)	n/a	n/a	n/a	3.5 GHz*[1]
Risetime (DSP Bandwidth Enhance)	n/a	n/a	n/a	115 ps
Hardware Analog Bandwidth (-3 dB)	500 MHz	1 GHz	2.5 GHz	2.5 GHz
Rise Time 10% to 90% (typical)	460 ps	300 ps	160 ps	145 ps
Rise Time 20% to 80% (typical)	310 ps	200 ps	100 ps	95 ps
DC Gain Accuracy	±1% with offset/position set to 0			
Bandwidth Limits	Depending on instrument model: 3.0 GHz, 2.5 GHz, 2 GHz, 1 GHz, 500 MHz, 250 MHz or 20 MHz			
Input Coupling	AC, DC, GND			
Input Impedance (software selectable)	1 MΩ ±1% with 13 pF ±2 pF or 50 Ω ± 1%			
Input Sensitivity	1 MΩ: 1 mV/div to 10 V/div 50 Ω: 1 mV/div to 1 V/div			
Vertical Resolution	8 bit (>11 bit with averaging)			
Max Input Voltage, 1 MΩ	±150 V CAT I, derate at 20 dB/decade to 9 V_{RMS} above 200 kHz			
Max Input Voltage, 50 Ω	5 V_{RMS}, with peaks less than ±24 V			
Position Range	±5 divisions			
Offset Range	1 mV/div to 50 mV/div: ±1 V 50.5 mV/div to 99.5 mV/div: ±1.5 V to 10 Divisions 100 mV/div to 500 mV/div: ±10 V 505 mV/div to 995 mV/div: ±15 V to 10 Divisions 1 V/div to 5 V/div: ±100 V 5.05 V/div to 10 V/div: ±150 V to 10 Divisions			
Offset Accuracy	1 mV/div to 9.95 mV/div: ±0.2% (offset value-position) ±0.1 div ±1.5 mV 10 mV/div to 99.5 mV/div: ±0.35% (offset value-position) ±0.1 div ±1.5 mV 100 mV/div to 1 V/div: ±0.35% (offset value-position) ±0.1 div ±15 mV 1.01 V/div to 10 V/div: ±0.25% (offset value-position) ±0.1 div ±150 mV			
Delay between any two channels (typical)	≤100 ps (50 Ω, DC coupling and equal V/div at or above 10 mV/div)			
Channel-to-channel Isolation (Any Two Channels at Equal Vertical Scale Settings) (typical)	≥100:1 at ≤100 MHz; ≥30:1 between 100 MHz and 2.5 GHz > 20:1 between 2.5 and 3.5 GHz			

*[1] 3 GHz for sine wave of more than 4 div amplitude (typically).

Time Base System

	DPO7054	DPO7104	DPO7254/DPO7354
Time Base Range	100 ps/div to 1000 s/div	50 ps/div to 1000 s/div	25 ps/div to 1000 s/div
with Opt. 2SR	50 ps/div to 1000 s/div	25 ps/div to 1000 s/div	-
Time Resolution (in ET/IT mode)	1 ps	500 fs	250 fs
with Opt. 2SR	500 fs	250 fs	-
Time Base Delay Time Range	5 ns to 250 s		
Channel-to-channel Deskew	Range ±75 ns		
Delta Time Measurement Accuracy	((0.06/sample rate)+(2.5 ppm x Reading)) RMS		
Trigger Jitter (RMS)	1.5 ps_{RMS} (typical) with enhanced triggering OFF < 100 fs_{RMS} with enhanced triggering ON		
Jitter Noise Floor	<1 ps_{RMS} (<2 ps peak) for record duration <10 µs (typical) <2.5 ps_{RMS} for record duration <30 ms <65 parts/trillion for record durations <10 s		
Time Base Accuracy	±2.5 ppm + Aging <1 ppm per year		

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Acquisition System

	DPO7054	DPO7104	DPO7254/DPO7354
Real-time Sample Rates			
1 channel (max)	10 GS/s	20 GS/s	40 GS/s
with Opt. 2SR	20 GS/s	40 GS/s	–
2 channels (max)	5 GS/s	10 GS/s	20 GS/s
with Opt. 2SR	10 GS/s	20 GS/s	–
3-4 channels (max)	2.5 GS/s	5 GS/s	10 GS/s
with Opt. 2SR	5 GS/s	10 GS/s	–
Equivalent Time Sample Rate (max)	4 TS/s (for repetitive signals)		
Maximum Record Length per Channel			
with Standard Configuration	40 M (1-CH.), 20 M (2-CH.), 10 M (4-CH.)		
with Record Length Opt. 2RL	80 M (1-CH.), 40 M (2-CH.), 20 M (4-CH.)		
with Record Length Opt. 5RL	200 M (1-CH.), 100 M (2-CH.), 50 M (4-CH.)		
with Record Length Opt. 10RL	–	–	400 M (1-CH.) 200 M (2-CH.) 100 M (4-CH.)

Maximum Duration at Highest Real-Time Resolution (1-CH)

	DPO7054	DPO7104	DPO7254/DPO7354
Resolution	100 ps (10 GS/s)	50 ps (20 GS/s)	25 ps (40 GS/s)
with Opt. 2SR	50 ps (20 GS/s)	25 ps (40 GS/s)	–
Max Duration with Standard Record Length and Sample Rate	4 ms	2 ms	1 ms
with Opt. 2SR	2 ms	1 ms	–
Max Duration with Opt. 2RL	8 ms	4 ms	2 ms
with Opt. 2SR	4 ms	2 ms	–
Max Duration with Opt. 5RL	20 ms	10 ms	5 ms
with Opt. 2SR	10 ms	5 ms	–
Max Duration with Opt. 10RL	–	–	10 ms

Acquisition Modes

	DPO7054/DPO7104/DPO7254/DPO7354
FastAcq Acquisition Mode	FastAcq optimizes the instrument for analysis of dynamic signals and capture of infrequent events
Maximum FastAcq Waveform Capture Rate	>250,000 wfms/s on all 4 channels simultaneously
Waveform Database	Accumulate waveform database providing three-dimensional array of amplitude, time and counts
Sample	Acquire sampled values
Peak Detect	Captures narrow glitches at all real-time sampling rates: 1/sample rate at ≤10 GS/s
Averaging	From 2 to 10,000 waveforms included in average
Envelope	From 1 to $2x10^9$ waveforms included in min-max envelope
Hi-Res	Real-time boxcar averaging reduces random noise and increases resolution
FastFrame™ Acquisition	Acquisition memory divided into segments; maximum trigger rate >310,000 waveforms per second Time of arrival recorded with each event. Frame finder tool helps to visually identify transients
Roll Mode	Up to 10 MS/s with a maximum record length of 40 M

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Pinpoint® Trigger System

	DPO7054/DPO7104/DPO7254/DPO7354
Sensitivity	
Internal DC Coupled	0.7 div DC to 50 MHz increasing to 1.2 div at rated analog bandwidth (typical); 2.5 div at 3.5 GHz with DSP Bandwidth enhance
External (Auxiliary Input) 1 MΩ	250 mV from DC to 50 MHz increasing to 350 mV at 250 MHz (typical)
Trigger Characteristics	
A Event and Delayed B Event Trigger Types	Edge, Glitch, Runt, Width, Transition Time, Timeout, Pattern, State, Setup/Hold, Window—all except Edge, Pattern and State can be Logic State qualified by up to two channels
Low Speed Serial Protocol Trigger Type (A Event only)	I^2C, SPI and RS-232 (standard). CANbus available as Opt. LSA Trigger on address, data and special handshaking states and other conditions
Main Trigger Modes	Auto, Normal and Single
Enhanced Triggering	User-selectable; it corrects the difference in timing between the trigger path and the acquired data path (it supports all Pinpoint trigger types on both A- and B-Events except pattern trigger and not available in FastAcq)
Trigger Sequences	Main, Delayed by Time, Delayed by Events, Reset by Time, Reset by State, Reset by Transition All sequences can include separate horizontal delay after the trigger event to position the acquisition window in time
Communications-Related Triggers	Requires Opt. MTM Support for AMI, HDB3, BnZS, CMI, MLT3 and NRZ encoded communications signals Select among isolated positive or negative one, zero pulse form or eye patterns as applicable to the standard
Serial Pattern Trigger	On DPO7254 or DPO7354 only and requires Opt. PTM Up to 64 bit serial word recognizer, bits specified in binary (high, low, don't care) or hex format Trigger on NRZ-encoded data up to 1.25 Gb/s
Video Type Trigger Formats and Field Rates	Triggers from negative sync composite video, field 1 or field 2 for interlaced systems, any field, specific line or any line for interlaced or noninterlaced systems Supported systems include NTSC, PAL, SECAM and HDTV 1080/24sF, 1080p/25, 1080i/50, 1080i/60, 1080p/24, 720p/60, 480p/60
Clock Recovery System	On DPO7254 or DPO7354 only and requires Opt. PTM or MTM
Clock Recovery Phase Locked Loop Bandwidth	Fixed at FBaud/500
Frequency Range	1.5 MBaud to 1.25 GBaud
Clock Recovery Jitter (RMS)	20 ps_{RMS} + 1.25% Unit Interval RMS for PRBS data patterns 20 ps_{RMS} + 1.25% Unit Interval RMS for repeating "0011" data pattern
Tracking/Acquisition Range	±5% of requested baud (typical)
Minimum Signal Amplitude needed for Clock Recovery	1 div_{p-p} up to 1.25 GBaud (typical)
Trigger Level Range Internal	±12 divisions from center of screen
AUX Trigger	TekVPI interface; ±5 V (50 Ω); 150 V CAT I, derate at 20 dB/decade to 9 V_{RMS} above 200 KHz (1 MΩ)
Line	Fixed at 0 V
Trigger Coupling	DC, AC (attenuates <60 Hz), HF Rej (attenuates >30 kHz), LF Rej (attenuates <80 kHz), Noise Reject (reduces sensitivity)
Trigger Holdoff Range	250 ns min to 12 s max

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Trigger Modes

Edge – Positive or negative slope on any channel or front panel auxiliary input. Coupling includes DC, AC, noise reject, HF reject and LF reject.

Glitch – Trigger on or reject glitches of positive, negative or either polarity. Minimum glitch width is down to 170 ps (typical) with rearm time of 250 ps (for DPO7254 or DPO7354).

Width – Trigger on width of positive or negative pulse either within or out of selectable time limits (down to 225 ps).

Runt – Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be time- or logic-qualified.

Timeout – Trigger on an event which remains high, low or either, for a specified time period. Selectable from 300 ps.

Transition – Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative or either.

Setup/Hold – Trigger on violations of both setup time and hold time between clock and data present on any two input channels.

Pattern – Trigger when pattern goes false or stays true for specified period of time. Pattern (AND or, NAND, NOR) specified for four input channels defined as high, low or don't care.

State – Any logical pattern of channels (1, 2, 3) clocked by edge on channel 4. Trigger on rising or falling clock edge.

Window – Trigger on an event that enters or exits a window defined by two user-adjustable thresholds. Event can be time- or logic-qualified.

Trigger Delay by Time – 5 ns to 250 s.

Trigger Delay by Events – 1 to 10,000,000 events.

Comm – Provided as part of Opt. MTM. Support for AMI, HDB3, BnZS, CMI, MLT3 and NRZ encoded signals.

I2C, SPI and RS-232 – Protocol trigger on DPO7054, DPO7154, DPO7254 or DPO7354.

CAN – Protocol trigger on DPO7054, DPO7154, DPO7254 or DPO7354 as part of Opt. LSA.

Serial Pattern (option PTM) – Captures serial data stream with built-in clock recovery for NRZ standards up to 1.25 Gb/s. Extended with pattern lock triggering to capture repeated acquisitions of long serial test patterns.

Search and Mark Events

Basic – Mark any events and document waveforms. Search positive, negative slopes or both on any channels. Event table summarizes all found events. All events are time stamped in reference to trigger position. Users can choose to stop acquisitions when an event is found.

Advanced – Search glitches or runts, as well as transition rate, pulse width, setup and hold, timeout, window violations or find any logic or state pattern on any number of channels. Search DDR read or write bursts with Opt. DDRA.

Waveform Measurements

Automatic Measurements – 53, of which 8 can be displayed on screen at any one time; measurement statistics, user-definable reference levels, measurement within gates isolating the specific occurrence within an acquisition to take measurements on.

Amplitude Related – Amplitude, High, Low, Maximum, Minimum, Peak to Peak, Mean, Cycle Mean, RMS, Cycle RMS, Positive Overshoot, Negative Overshoot.

Time Related – Rise Time, Fall Time, Positive Width, Negative Width, Positive Duty Cycle, Negative Duty Cycle, Period, Frequency, Delay.

Combination – Area, Cycle Area, Phase, Burst Width.

Histogram Related – Waveform Count, Hits in Box, Peak Hits, Median, Maximum, Minimum, Peak to Peak, Mean (μ), Standard Deviation (sigma), μ+1sigma, μ+2sigma, μ+3sigma.

Eye Pattern Related – Extinction Ratio (absolute, %, dB), Eye Height, Eye Width, Eye Top, Eye Base, Crossing %, Jitter (p-p, RMS, 6sigma), Noise (p-p, RMS), Signal/Noise Ratio, Cycle Distortion, Q-Factor.

Waveform Processing/Math

Arithmetic – Add, Subtract, Multiply, Divide Waveforms and Scalars.

Algebraic Expressions – Define extensive algebraic expressions including Waveforms, Scalars, User-Adjustable Variables and Results of Parametric Measurements e.g., (Integral (CH.1-Mean(CH.1))x1.414xVAR1).

Math Functions – Average, Invert, Integrate, Differentiate, Square Root, Exponential, Log10, Log e, Abs, Ceiling, Floor, Min, Max, Sin, Cos, Tan, ASin, ACos, ATan, Sinh, Cosh, Tanh.

Relational – Boolean result of comparison >, <, >=, <=, ==, !=.

Frequency Domain Functions – Spectral Magnitude and Phase, Real and Imaginary Spectra.

Vertical Units –
Magnitude: Linear, dB, dBm,
Phase: Degrees, radians, group delay
IRE and mV units.

Window Functions – Rectangular, Hamming, Hanning, Kaiser-Bessel, Blackman-Harris, Gaussian, Flattop2, Tek Exponential.

Waveform Definition – As an arbitrary math expression.

Filtering Functions – User-definable filters. Users specify a filter containing the coefficients of the filter. Filter files provided.

Mask Function – A function that generates a Waveform Database pixmap from a sample waveform. Sample count can be defined.

Display Characteristics

Display Type – Liquid crystal active-matrix color display.

Display Size – Diagonal: 307.3 mm (12.1 in.).

Display Resolution – XGA 1240 horizontal x 768 vertical pixels.

Waveform Styles – Vectors, Dots, Variable Persistence, Infinite Persistence.

Color Palettes – Normal, Green, Gray, Temperature, Spectral and User-defined.

Display Format – YT, XY.

Computer System and Peripherals

Operating System – Windows XP.

CPU – Intel Pentium 4, 3.4-GHz processor.

PC System Memory – 2 GB.

Hard Disk Drive – Rear-panel, removable hard disk drive, 80 GB capacity.

CD-R/W Drive – Front-panel CD-R/W drive with CD creation software application.

DVD Drive – Read only.

Mouse – Optical wheel mouse, USB interface.

Printer (optional) – Thermal printer; fits in accessories pouch provided with instrument.

Keyboard – Order 119-7083-00 for small keyboard (fits in pouch); USB interface and hub.

Input/Output Ports

Front Panel

Probe Compensator Output – Front panel pins. Amplitude 1 V ±20% into a ≥50 Ω load; 500 mV from base to top into a 50 Ω load, frequency 1 kHz ±5%.

Recovered Clock (for DPO7254 or DPO7354 only) – BNC connector, ≤1.25 Gb/s, Output swing ≥130 mVp-p into 50 Ω. Requires option to enable.

Recovered Data (for DPO7254 or DPO7354 only) – BNC connector , ≤1.25 Gb/s, Output swing 200 mV into 50 Ω. Requires option to enable.

USB 2.0 Port – One USB 2.0 connector.

Aux Trigger Input – See Trigger specification.

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Side Panel

Parallel Port – IEEE 1284, DB-25 connector.

Audio Ports – Miniature phone jacks (disabled).

Keyboard Port – PS-2 compatible.

Mouse Port – PS-2 compatible.

USB Ports – Four USB 2.0 connectors.

LAN Port – RJ-45 connector, supports 10Base-T, 100Base-T and Gigabit Ethernet.

Serial Port – DB-9 COM1 port.

VGA Video Port – DB-15 female connector; connect a second monitor to use dual-monitor display mode. Supports basic requirements of PC99 specifications.

Oscilloscope VGA Video Port – DB-15 female connector, 31.6 kHz sync, EIA RS-343A compliant, connect to show the oscilloscope display, including live waveforms on an external monitor or projector.

Rear Panel

Power –
100 to 240 VRMS ± 10%, 47 to 63 Hz, <550 W
115 VRMS ± 10%, 400 Hz,
CAT I, <500 VA.

Analog Signal Output – BNC connector provides a buffered version of the signal that is attached to the Ch 3 input.

Amplitude – 50 mV/div ±20% into a 1 MΩ load, 25 mV/div ±20% into a 50 Ω load.

Bandwidth – 100 MHz into a 50 Ω load.

Software – Switchable BNC Connector.
External Time Base Reference In – BNC connector, time base system can phase-lock to external 10 MHz reference.
Time Base Reference Out – BNC connector, provides TTL-compatible output of internal 10 MHz reference oscillator.

Aux Trigger Output – BNC connector provides a TTL-compatible, polarity switchable pulse when the oscilloscope triggers.

GPIB Port – IEEE 488.2 standard.

Physical Characteristics

Benchtop Configuration

Dimensions	mm	in.
Height	292	11.48
Width	451	17.75
Depth	265	10.44

Weight	kg	lbs.
Net	15	32
Shipping	28.9	63.75

Rackmount Configuration

Dimensions	mm	in.
Height	323	12.25
Width	479	18.85
Depth (from rackmounting ear to back of instrument)	231.75	9.12

Weight	kg	lbs.
Net	17.4	37.5
Rackmount Kit	2.5	5.5

Mechanical

Cooling — Required Clearance

	mm	in.
Top	0	0
Bottom	0	0
Left side	76	3
Right side	0	0
Front	0	0
Rear	0	0

Environmental

Temperature

Operating – 0 ºC to +50 ºC, excluding CD-R/W drive; +10 ºC to +45 ºC, including CD-R/W drive.

Nonoperating – –40 ºC to +71 ºC.

Humidity

Operating – 5% to 95% relative humidity (RH) with a maximum wet bulb temperature of +29 ºC at or below +50 ºC, noncondensing. Upper limit derated to 45% RH above +30 ºC up to +50 ºC.

Nonoperating – 5% to 95% relative humidity (RH) with a maximum wet bulb temperature of +29 ºC at or below +60 ºC, noncondensing. Upper limit derated to 45% RH above +30 ºC up to +50 ºC.

Altitude

Operating – 10,000 ft. (3,048 m).

Nonoperating – 40,000 ft. (12,190 m).

Random Vibration

Operating – 0.000125 G2/Hz from 5 to 350 Hz, –3 dB/octave from 350 to 500 Hz, 0.0000876 G2/Hz at 500 Hz. Overall level of 0.27 GRMS.

Nonoperating – 0.0175 G2/Hz from 5 to 100 Hz, –3 dB/octave from 100 to 200 Hz, 0.00875 G2/Hz from 200 to 350 Hz, –3 dB/octave from 350 to 500 Hz, 0.006132 G2/Hz at 500 Hz. Overall level of 2.28 GRMS.

Regulatory

Electromagnetic Compatibility – 93/68/EEC; EN61326:1997 +A1 1998+A2:2000.

Certifications – UL 3111-1, CSA1010.1, ISO11469, EN61010-1, IEC 61010-1.

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Ordering Information

DPO7000 Series

DPO7054 – 500 MHz Digital Phosphor Oscilloscope.

DPO7104 – 1 GHz Digital Phosphor Oscilloscope.

DPO7254 – 2.5 GHz Digital Phosphor Oscilloscope.

DPO7354 – 3.5 GHz Digital Phosphor Oscilloscope for Serial and Digital applications.

All Models Include: Accessory pouch, front cover, mouse, quick-start user manual (071-173x-xx), DPO7000 Series product software media, DPO7000 Series operating system restoration media, Optional applications software media, performance verification procedure PDF file, GPIB programmer's reference (on product software media), calibration certificate documenting NIST traceability, Z 540-1 compliance and ISO9001, power cord, one-year warranty. **Note:** User to specify quick-start user manual language and power plug when ordering. DPO7054 also includes: (4) P6139A 500 MHz, 10x passive probes. (Probes and accessories are not included in the oscilloscope warranty. Refer to the data sheet for each probe for its unique warranty and calibration terms.)

Options

Instrument Options

Record Length Options

Opt. 2RL – 80 MSamples max, 20 MSamples/ch.

Opt. 5RL – 200 MSamples max, 50 MSamples/ch.

DPO7254/DPO7354 only.

Opt. 10RL*1 – 400 MSamples max, 100 MSamples/ch.

Hardware Options

Opt. 1P – Thermal printer in the pouch. Printer option is available for all models.

DPO7104/DPO7054 only

Opt. 2SR*2 – Double maximum real-time sample rate.

DPO7104 – 40 GS/s (1 channel), 20 GS/s (2 channels), 10 GS/s (3 or 4 channels).

DPO7054 – 20 GS/s (1 channel), 10 GS/s (2 channels), 5 GS/s (3 or 4 channels).

Software Options

Opt. DDRA*3 – DDR Memory Bus Analysis.

Opt. DJA – DPOJET Jitter and Eye-Diagram Analysis - Advanced.

Opt. DJE – DPOJET Jitter and Eye-Diagram Analysis - Essentials.

Opt. LSA – Low Speed Serial Analysis includes CAN/LIN Trigger, Decode and Analysis.

Opt. MTM – Mask Testing for Serial Communication Standards (up to 1.5 Gb/s) – Includes hardware clock recovery on DPO7254/DPO7354.

*1 DPO7254 or DPO7354 only.

*2 DPO7054 and DPO7104 only.

*3 Requires DJA and ASM.

Opt. LT – Limit Testing.

Opt ASM – Advanced Event Search and Mark.

Opt. ET3*4 – TDSET3 Ethernet Compliance Test Software.

Opt. USB*5 – TDSUSBS USB 2.0 Compliance Test Software only.

Opt. UWBE6 – Ultra-Wideband Spectral Analysis Essentials.

Opt. UWB*6 – Ultra-Wideband Spectral Analysis Software.

Opt. PWR – DPOPWR Power Measurement and Analysis Software.

Opt. SVE – SignalVu™ Essentials – Vector Signal Analysis Software.

Opt. SVP*7 – Advanced Signal Analysis (including pulse measurements). Requires option SVE.

Opt. SVM*7 – General Purpose Modulation Analysis. Requires option SVE.

DPO7254/DPO7354 only

Opt. PTM*1 – 8b/10b protocol triggering and NRZ serial pattern triggering. Includes hardware clock recovery up to 1.5 Gb/s and pattern lock triggering.

Opt. RTE*1 – RT-Eye® Serial data compliance and analysis software.

DPO7354 only

Opt. DVI*6 – Digital Visual Interface compliance test software.

Bundle Options

Opt. PS1 – Power Bundle option includes TPA, BNC adapter, Probe Calibration and deskew fixture 067-1686-xx, P5205, TCP0030 and Opt. PWR.

User Manual Options

Opt. L0 – English manual.

Opt. L1 – French manual.

Opt. L3 – German manual.

Opt. L5 – Japanese manual.

Opt. L7 – Simple Chinese manual.

Opt. L8 – Standard Chinese manual.

Opt. L9 – Korean manual.

Opt. L10 – Russian manual.

Power Plug Options

Opt. A0 – North America.

Opt. A1 – Universal European Union.

Opt. A2 – UK.

Opt. A3 – Australia.

Opt. A5 – Switzerland.

Opt. A6 – Japan.

Opt. A10 – China.

Opt. A11 – India.

Opt. A99 – No power cord.

*4 Requires Ethernet Test Fixture.

*5 Requires TDSUSBF (USB Test Fixture).

*6 DPO7354 only.

Service Options

(Probes and accessories are not included in the oscilloscope warranty. Refer to the data sheet for each probe for its unique warranty and calibration terms.).

Opt. C3 – Calibration Service 3 Years.

Opt. C5 – Calibration Service 5 Years.

Opt. D1 – Calibration Data Report.

Opt. D3 – Calibration Data Report 3 Years (with Opt. C3).

Opt. D5 – Calibration Data Report 5 Years (with Opt. C5).

Opt. R3 – Repair Service 3 Years.

Opt. R5 – Repair Service 5 Years.

Recommended Accessories

Probes

TCP0150 – 20 MHz TekVPI™ AC/DC 150 A current probe.

TCP202*6 – DC coupled current probe.

TDP0500 – 500 MHz TekVPI high voltage differential probe.

TDP1000 – 1 GHz TekVPI high voltage differential probe.

TDP1500 – 1.5 GHz TekVPI high voltage differential probe.

TDP3500 – 3.5 GHz TekVPI high voltage differential probe.

TAP3500 – 3.5 GHz TekVPI active single-ended probe.

TAP2500 – 2.5 GHz TekVPI active single-ended probe.

TAP1500 – 1.5 GHz TekVPI active single-ended probe.

TCP0030 – >120 MHz TekVPI AC/DC 30 A current probe.

TPA-BNC – TekProbe-BNC Level 2 to TekVPI adapter.

P6139A – 500 MHz, passive probe.

P6158 – 3 GHz, 20x low C probe.

P6247*8 – 1 GHz differential probe.

P6243*8 – 1 GHz active probe.

P6245*8 – 1.5 GHz active probe.

P6248*8 – 1.5 GHz differential probe.

P6330*8 – 3 GHz differential probe.

P6246*8 – 400 MHz differential probe.

P6101B – 1x passive probe 15 MHz.

TCPA300/TCPA400*8 – Series current measurement systems.

P5200/P5205/P5210*8 – High voltage differential probes.

P5100/P6015A – High voltage probes.

*7 Requires Opt. SVE or SVEM.

*8 Probe requires TPA-BNC adapter.

TEST EQUIPMENT SOLUTIONS
Quality Second User Test Equipment for Sale or Rental
www.TestEquipmentSolutions.com
sales@testequipmentsolutions.com

Cables

GPIB Cable (1 m) – Order 012-0991-01.

GPIB Cable (2 m) – Order 012-0991-00.

RS-232 Cable – Order 012-1298-00.

Centronics Cable – Order 012-1214-00.

Accessories

Mini Keyboard (USB interface) – Order 119-7083-00.

Keyboard (USB interface) – Full-size keyboard with 4 port USB hub. Order 119-6297-00.

Service Manual – Order 071-1740-xx.

Instrumented DIMM for DDR3 – Order scope NEXVu card for UDIMM Raw Card E (Contact www.nexustechnology.com).

Transit Case – Order 016-1970-00.

Video Display Clamp Order – Order 013-0278-xx.

Rackmount Kit – Order 016-1985-xx.

Removable HD Spare – Order 065-0744-xx.

Oscilloscope Cart – Order K420 (requires 407-5192-00 bracket set).

Thermal Printer Paper – Order 016-1969-00.

WaveStar™ – Windows application for remote access.

Test Fixtures

TDSUSBF – Test fixture for use with Opt. USB.

Probe Calibration/Power Deskew Fixture – Order 067-1686-xx.

Ethernet Test Fixture – Order through Crescent Heart Software (http://www.c-h-s.com).

Adapters

AMT75 – 1 GHz 75 Ω adapter.

P6701B*1 – Optical/electrical converter (multi mode).

P6703B*1 – Optical/electrical converter (single mode).

*1 Probe requires TPA-BNC adapter.

*2 DPO7254 or DPO7354 only.

*3 DPO7354 only.

*4 Requires DJA and ASM.

*5 Requires Ethernet Test Fixture.

*6 Requires TDSUSBF (USB Test Fixture).

Instrument Upgrades

To upgrade your DPO7000 Series Oscilloscope order option as noted:

To upgrade record length:

DPO7UP with Opt. RL02 – From standard configuration to Opt. 2RL configuration.
RL05 – From standard configuration to Opt. 5RL configuration.
RL010*2 – On DPO7254 or DPO7354 from standard configuration to Opt. 10RL configuration.
RL25 – From Opt. 2RL configuration to Opt. 5RL configuration.
RL210*2 – On DPO7254 or DPO7354 from Opt. 2RL configuration to Opt. 10RL configuration.
RL510*2 – On DPO7254 or DPO7354 from Opt. 5RL configuration to Opt. 10RL configuration.

To upgrade DPO7000 Series with:

DVI*3 – Opt. DVI.
RTE*2 – Opt. RTE or TDSRT-Eye software.
LSA – Opt. LSA.
LT – Opt. LT.
ASM – Opt. ASM.
DDRA*4 – Opt. DDRA.
DJAM – Opt. DJA.
DJEM – Opt. DJE.
ET3*5 – Opt. ET3.
USB*6 – Opt. USB.
UWBE*5 – Opt. UWBE.
UWB*5 – Opt. UWB.
MTM – Opt. MTM.
PWR – Opt. PWR.
SVEM – Opt. SVE.
SVP*7 – Opt. SVP.
SVM*7 – Opt. SVM.

Other Upgrades:

PTM*2 – To upgrade DPO7254 or DPO7354 with Opt. PTM.
CP2*8 – TDSCPM2 ANSI/ITU Telecom pulse compliance testing software (requires Opt. MTM on DPO7000 Series).
J2 – TDSDDM2 disk drive analysis software.
1P – Thermal Printer.

*7 Requires Opt. SVE or SVEM.

*8 Requires Opt. MTM.

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For Further Information

Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit **www.tektronix.com**

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